MMFE-8 Noise Measurements at Arizona

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MM Signal

- The charge from a MIP is approximately 80 fC
 50e x 10e4 x 1.6e-19 x 1e15
- And is distributed over ~5 strips: 16 fC / strip
- So the output signal (MO) is
 - 48, 144, 256 mV
 - For VMM gain of 3, 9, 16 mV/fC

Intrinsic VMM Noise

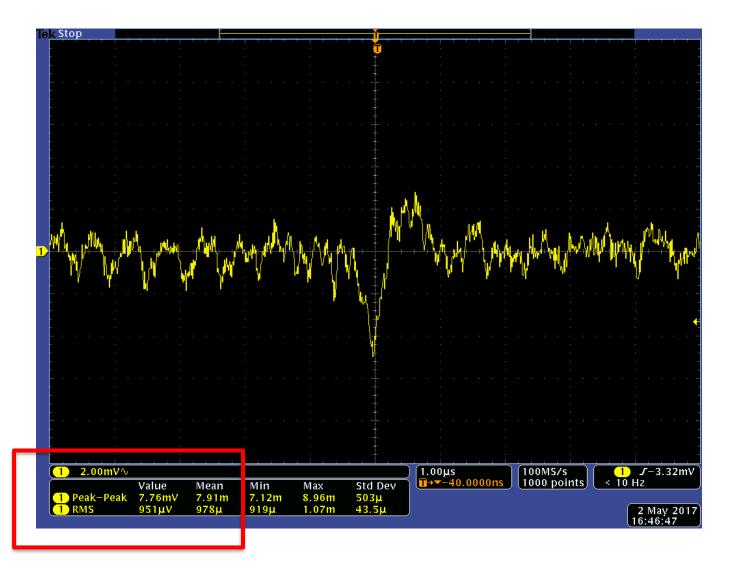
- $ENC(electrons) = (250 + 10 \cdot C_{det}) \sqrt{\frac{200ns}{\tau_{peak}}}$
- For VMM parasitic capacitance of 23 pf

						3 mV/fC	9 mV/fC	16 mV/fC
	pf	ns	ns	electrons	fC	mV	mV	mV
q	cdet	tp0	tp	enc	enc	mo	mo	mo
1.60E-19	23	200	200	480	0.077	0.23	0.69	1.23
1.60E-19	23	200	100	678.82251	0.109	0.33	0.98	1.74
1.60E-19	23	200	50	960	0.154	0.46	1.38	2.46
1.60E-19	23	200	25	1357.64502	0.217	0.65	1.96	3.48

Noise Measurement Procedure

- Use MO, terminated at 1 Mohm
- Trigger scope at largest negative value where the pulse still triggers
- Initially, we recorded RMS value of MO about 5 times and average
 - More recently we record value and mean of both RMS and peak-peak values
 - Recall MO output includes both intrinsic VMM noise and DCDC ripple noise
- Sometimes we also add a 27pf or 220pf external capacitor to the channel input

Noise Measurement Procedure



Filtering

- We are constantly working to improve the filtering by appropriate choice of capacitors, inductors and their basic (SRF) properties
- Thus there is some variation, especially in early measurements, because snapshots were collected with different filtering values

Rev C

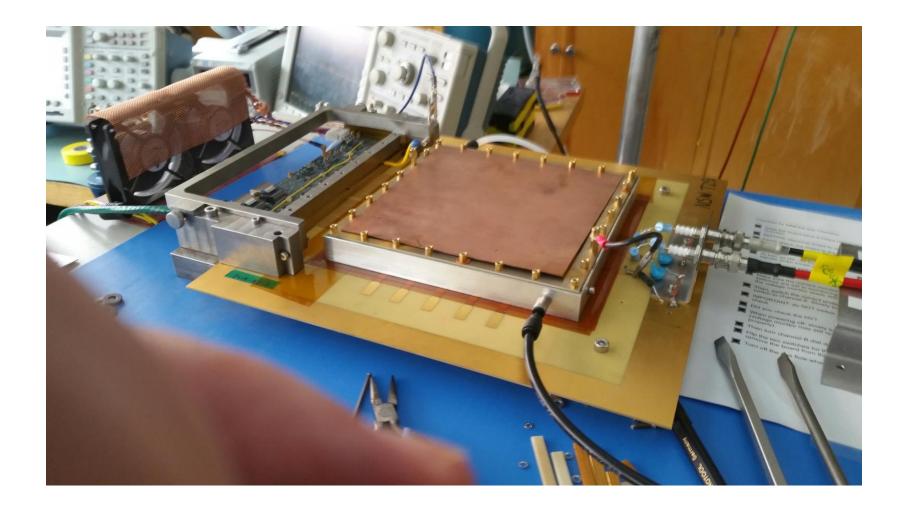
• Early bench measurements

mV	pf	mV /fC	ns	mV	mV	mV	
output rms	c det	gain	peak time	output rms	vmm intrinsio	vmm ripple	ratio ripple/intring
measured				measured	calculated	extracted	
0.29	23	3	200	0.29	0.23	0.18	0.79
0.41	50	3	200	0.41	0.36	0.19	0.53
0.46	247	3	200	0.46	1.31	#NUM!	#NUM!
0.32	23	9	200	0.32	0.69	#NUM!	#NUM!
0.38	50	9	200	0.38	1.08	#NUM!	#NUM!
1.69	247	9	200	1.69	3.92	#NUM!	#NUM!
0.32	23	16	200	0.32	1.23	#NUM!	#NUM!
0.43	50	16	200	0.43	1.92	#NUM!	#NUM!
3.51	247	16	200	3.51	6.96	#NUM!	#NUM!
0.32	23	9	200	0.32	0.69	#NUM!	#NUM!
0.38	50	9	200	0.38	1.08	#NUM!	#NUM!
1.69	243	9	200	1.69	3.92	#NUM!	#NUM!

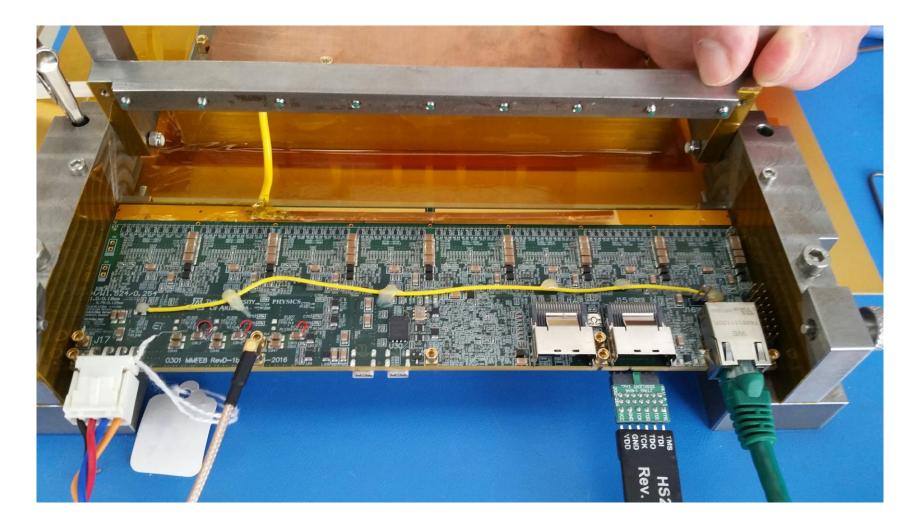
• Bench

			same as col a		st	vmm2+fea	3/7/2017
			mo				mo
	mV	mV	mV	ns	mV /fC	pf	mV
ripple/intrin	vmm ripple	vmm intrinsio	output rms	peak time	gain	c det	output rms
	extracted	calculated	measured				measured
1.28	0.29	0.23	0.37	200	3	23	0.37
0.50	0.18	0.25	0.37	200	3		0.37
#NUM!	#NUM!	1.29	1.28	200	3	243	1.28
0.72	0.50	0.69	0.85	200	9	23	0.85
0.27	0.30	1.08	1.12	200	9	50	1.12
#NUM!	#NUM!	3.86	3.09	200	9	243	3.09
0.76	0.93	1.23	1.54	200	16	23	1.54
#NUM!	#NUM!	1.92	1.67	200	16	50	1.67
#NUM!	#NUM!	6.86	5.38	200	16	243	5.38

AZ MM Test Chamber



AZ MM Test Chamber



• Bench and MM Test Chamber (AZ)

mV /	/fC		mo				
mV /	/fC						
		ns	mV	mV	mV		
t gain		peak time	output rms	vmm intrinsio	vmm ripple	ratio ripple/intr	insic
			measured	calculated	extracted		
23	3	200	0.29	0.23	0.18	0.78	bench
23	9	200	0.42	0.69	#NUM!	#NUM!	bench
23	16	200	0.62	1.23	#NUM!	#NUM!	bench
50	3	200	0.84	0.36	0.76	2.11	mm test
50	9	200	2.28	1.08	2.01	1.86	mm test
50	16	200	3.81	1.92	3.29	1.71	mm test
	23 23 50 50	23 9 23 16 50 3 50 9	23 3 200 23 9 200 23 9 200 23 16 200 50 3 200 50 9 200	23 9 200 0.42 23 16 200 0.62 50 3 200 0.84 50 9 200 2.28	23 3 200 0.29 0.23 23 9 200 0.42 0.69 23 16 200 0.62 1.23 23 16 200 0.62 1.23 50 3 200 0.84 0.36 50 9 200 2.28 1.08	23 3 200 0.29 0.23 0.18 23 9 200 0.42 0.69 #NUM! 23 16 200 0.62 1.23 #NUM! 23 16 200 0.62 1.23 #NUM! 50 3 200 0.84 0.36 0.76 50 9 200 2.28 1.08 2.01	23 3 200 0.29 0.23 0.18 0.78 23 9 200 0.42 0.69 #NUM! #NUM! 23 16 200 0.62 1.23 #NUM! #NUM! 23 16 200 0.62 1.23 #NUM! #NUM! 50 3 200 0.84 0.36 0.76 2.11 50 9 200 2.28 1.08 2.01 1.86

• See Ryan's talk

Conclusions

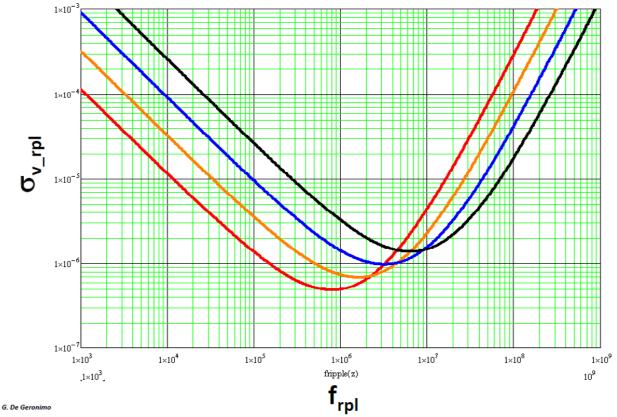
- For all boards (RevC, VMM2+Feast, VMM3 Feast), bench measurements of the MMFE8 noise as measured as MO are approximately the level of the intrinsic noise
- Using the AZ MM test chamber and VMM2+FEAST board shows MMFE noise about a factor of 2 times the intrinsic noise
- Not presented, but there is consistency between noise measurements made using the MO and those from XADC data
- Additional noise suppression can be accomplished by continued optimization of the filtering capacitors

Backup

Power Noise Goal

- Keep ENC ripple close to intrinsic ENC
- Roughly < 10 uV at vddp

Maximum tolerable σ_{v_rpl} vs frequency for VMM at different peaking times (200ns, 100ns, 50ns, 25ns)



Measurements Made

- Rev C (VMM2 + COTS DCDC + LDO)
 - Repeated measurements as done at BNL (baseline)
 - Measurements taken on test MM chamber
 - Measurements taken with shield both on and off using MM chamber
 - Measurements taken with improved pi filters (additional C on either side of pi filters)
 - Measurements taken using external lab supplies to power a Rev C board
 - Measurements taken using one Rev C board to power another Rev C board
 - Measurements with different input C

Measurements Made

- Feast V1 (VMM2 + FEAST + no LDO)
 - Baseline measurements
 - Measurements with improved pi filter
 - Measurements with external power
 - Measurements with different input C

Rev C/Rev D

- Noise Filter Design
 - A Low noise LT8612 DCDC, ripple < 10mV</p>
 - $60 = 20 \log(0.00001/0.01)$
 - A Low noise LDO ADP1755, ripple < 23uV RMS, PSRR > 54db @100KHz
 - 7 = 20 log(0.00001/0.000023)
 - A series of 2nd order LPF's, (PI filters) 12db / octave, 40db / decade
 - First LPF @32KHz (320KHz = 40db), (640KHz = 52db), (1.28 MHz = 64db)
 - Second LPF @18KHz (180KHz = 40db), (680KHz = 64db), (1.36MHz = 76db)
 - All calculated to yield the desired 10uV ripple
 - Verified by simulation

Changes to Rev D

- Minimal changes from Rev C
 - 14 -> 16 layer stack, 8 power / ground planes
 - Standard BOM configures as un-optimized DCDC configuration
 - Power design abandoned since it failed radiation tests
 - ADGnd inductors replaced with 0 ohm resistor due to large power oscillations
 - Modified clock, mode, sync, and power inductor to reduce noise from 350mV -> 50-100mV
 - Verified noise due to DCDC converter as noise signature follows clock speed changes
 - Added wire to fix VMM power droop on VMM's 6, 7, 8

Changes to VMM2 + FEAST

- 14 -> 16 layer stack, 8 power / ground planes
- Analog / AD / Digital power and ground planes aligned
- Caps added to all power rails
- DCDC's and output coil's re-located away from VMM's
- Error caused failure of Isolated grounds and shields implemented for DCDC and output coils
- MO re-routed over AGND not [digital]GND
- DCDC configuration modified slightly to compensate for power droop
- ADGnd inductors kept as 0 ohm resistor due to large power oscillations.
- LDO removed since it is not rad hard

Changes to VMM3 + FEAST

- Analog / AD / Digital power and ground planes simplified and further aligned
- Added Feast Temperature sensors
- Added Rad Hard LDO back into design (but DNP!)
- Even more caps added to all power rails
- DCDC's and output coil's remain located away from VMM's
- Isolated grounds and shields implemented for DCDC and output coils
- DCDC configuration modified slightly to compensate for power droop
- ADGnd inductors kept as 0 ohm resistor due to large power oscillations
- DCDC input output filters reconfigured as anti-parallel
- Anti-parallel caps added to iso dcdc inputs, outputs
- Isolated clip pads installed for iso shields... connected to PGND
- Cutout for input capacitance reduced in size, AGND added across cavern

Bench and MM Test Chamber (AZ)

+ feast mo mV rms output rms red measured ean pp value	mo mV	vmm3+fea pf c det	ast mV /fC gain	ns	same as col a mo mV		mV		
mV rms output rms red measured	mV output rms		-	ns		mV	m\/		
rms output rms red measured	output rms		-		mV	mV	m\/		
red measured		c det	gain			(111 Y	iiiv /		
	measured		0	peak time	output rms	vmm intrinsi	(vmm ripple	ratio ripple/intr	/insic
an pp value					measured	calculated	extracted		
	pp mean								
0.61 4.08	8 3.75	5 23	3 3	3 200	0.59	0.23	0.54	2.36	bench
0.72 5.40	0 5.31	L 23	3 9	200	0.71	0.69	0.14	0.20	bench
1.06 7.28	8 7.69	23	3 16	5 200	1.08	3 1.23	#NUM!	#NUM!	bench
0.97 7.44	4 7.20	i 50) 3	3 200	1.00	0.36	i 0.93	2.59	mm test
2.52 19.20	0 18.40	50) 9	200	2.54	1.08	2.30	2.13	mm test
4.15 29.80	0 29.70	50) 16	5 200	4.34	1.92	3.89	2.03	mm test
1.05 7.84	4 7.19	50) 3	3 200	1.06	o 0.36	i 1.00	2.77	mm + shields
2.61 15.20	0 16.70	50) 9	200	2.71	1.08	3 2.49	2.30	mm + shields
4.48 26.00	0 27.10	50) 16	5 200	4.56	i 1.92	4.14	, 2.15	mm + shields
	0.97 7.44 2.52 19.20 4.15 29.80 1.05 7.84 2.61 15.20	0.97 7.44 7.20 2.52 19.20 18.40 4.15 29.80 29.70 1.05 7.84 7.19 2.61 15.20 16.70	Image: Non-state state st	Image: system of the	Image: Non-state state st	Image: Non-state state st	Image: Non-state state st	Image: Non-Strain of the strain of	Image: Note of the image: No

• Bench with external capacitors

mo	mo	mo	mo				mo				
mV	mV	mV	mV	pf	mV /fC	ns	mV	mV	mV		
output rms	output rms	output rms	output rms	c det	gain	peak time	output rms	vmm intrinsic	vmm ripple	ratio ripple/intring	sic
measured	measured	measured	measured				measured	calculated	extracted		
rms value	rms mean	pp value	pp mean								_
											-
0.41	. 0.49	2.96	5 2.86	23	3	3 200	0.41	. 0.23	0.34	1.49	÷
0.61	0.62	4.12	4.49	50	3	3 200	0.61	0.36	i 0.49	1.37	7 1
3.39	3.16	19.80	19.60	243	3	3 200	3.39	1.29	3.14	2.44	4 v
0.69	0.72	5.56	5.43	23	9	200	0.69	0.69	#NUM!	#NUM!	v
1.41	1.43	9.60	9.95	50	9	200	1.41	. 1.08	0.91	. 0.84	1 ۱
8.94	8.48	56.40	50.90	243	9	200	8.94	3.86	8.06	2.09	۶ı
1.09	1.06	7.20	7.50	23	16	j 200	1.09	1.23	#NUM!	#NUM!	١
2.11	2.35	17.40	16.30	50	16	j 200	2.11	1.92	0.88	0.46	5 1
15.60	14.40	95.20	86.30	243	16	5 200	15.60	6.86	i 14.01	2.04	4 1